

University Science Instrumentation Centre (USIC)
University Of Delhi, Delhi-110007

Date: __/__/__

Requisition Form for Using the Facility of Atomic Force Microscopy
(AFM)

1. Name of the Scholar: _____
2. Name of the Supervisor: _____
3. No. of Samples: _____
4. Sample Code: _____
5. Nature of sample (Hard/Soft): _____
6. Specifications of samples: Material(s) and Substrate (if any): _____

7. Mode of AFM (Contact/Amplitude modulation/Others): _____
8. Scan size required: _____
9. Any other remarks: _____
10. Please tick (if any)
 - I. Are the samples hazardous (Yes/No): _____
 - II. Are the samples infectious (Yes/No): _____
 - III. Are the samples pathogenic (Yes/No): _____

Instructions for the users:

- I. Samples will not be accepted for analysis unless accompanied by a duly completed submission form.
- II. If user has any specific instructions regarding the analysis, he/she discuss with the operator.
- III. User must report at the AFM lab as per the scheduled appointment (date & time).
- IV. Samples should be brought by the user at the allotted time and the user should be present while the samples are being examined.

Important Note*: The sample must be a completely dry, thin film synthesized using an appropriate scientific method.

Signature of Student

/Scholar: _____

Course: _____

Contact Number: _____

Signature of the

Supervisor: _____

Department

(with Seal): _____

Signature:

Director, USIC